Compatibility Analyses of BICUVOX.10 as a Cathode in Yttria-stabilized Zirconia Electrolytes for Usage in Solid Oxide Fuel Cells

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Copper-substituted bismuth vanadate has been considered a promising material for composite cathodes in SOFC. However, high reactivity of BICUVOX.10 towards the electrolytes still has been its greatest shortcoming. This paper describes reactions between BICUVOX.10 and yttria-stabilized zirconia (YSZ) electrolytes. Secondary phases formed were evaluated by X-ray diffraction, scanning electron microscopy and a.c. impedance spectroscopy. A deleterious interaction between BICUVOX.10 and YSZ was observed, mainly regarding the yttrium depletion from ZrO_2 lattice through reaction with $VO_{2.5}$, resulting in YVO₄ phase nucleation and destabilization of the tetragonal and cubic ZrO_2 polymorphs to monoclinic. The ZrO_2 destabilization and YVO₄ nucleation are related phenomena and were interpreted through a theoretical mechanism using charge-compensating dopants description. Thus, these reactions were seen as detrimental to the cathode/electrolyte contact, especially regarding the highly resistive layer formed in the BICUVOX.10/YSZ junction, discouraging further usage of BICUVOX.10 as a cathode in yttria-stabilized zirconia electrolytes.

Keywords: BICUVOX.10, YSZ, cathode, destabilization, SOFC

1. Introduction

Costs for broad commercialization of solid oxide fuel cells (SOFC) can be considerably reduced by lowering the operation temperature of such devices¹⁻³. Nowadays, the process to reduce the operating temperature is still limited by the insufficient oxygen transport across the electrolyte at low temperatures. However, Xia and Liu⁴ proposed that a significant reduction in the SOFC operating temperature can be obtained through the development of composite cathodes with higher catalytic activity for oxygen reduction, thereby offering high power densities without exchanging the electrolyte.

A proposed alternative material with high ionic conductivity in such composite cathodes by Xia and Liu⁴ is copper-substituted bismuth vanadate (BICUVOX.10)⁵⁻⁷. The ionic conductivity of BICUVOX.10 at 300 °C is in the order of 10^{-3} S.cm⁻¹, value almost 100 times greater than any other solid electrolyte at this temperature⁵⁻⁷. Considering such BICUVOX.10 feature, significant research has been conducted using this material as a cathode composite together with gadolinia-doped ceria electrolytes (GDC)^{3,8,9}. It was found that the interfacial cathodic polarization between the composite cathode BICUVOX.10/Ag and a GDC electrolyte at 500 °C is of merely 0.53 Ω .cm², value much lower than those obtained when using $La_{0.6}Sr_{0.4}Co_{0.2}Fe_{0.8}O_{3-\delta}$ (LSCF) or $Sm_{0.5}Sr_{0.5}CoO_{3-\delta}$ (SSC) cathodes.

Despite these interesting BICUVOX.10 characteristics, the main problem identified during the application of this material as a cathode is its high reactivity towards the electrolyte. A.J. Samson et al.¹⁰ observed that the temperature required to achieve a coating with good adhesive characteristics at the junction of BICUVOX.10+LSC(cathode) / GDC(electrolyte) is high enough to allow interfacial reactions, leading to inappropriate ionic transport through the reaction zone in the cathode/electrolyte interface. However - regarding the formed products and their properties - these reaction zones have not been fully examined. Furthermore, it has been reported by Z. Shao et al.11 that mixtures of BICUVOX.10 + Sm_{0.15}Ce_{0.85}O_{1.925} (SDC) gave rise to secondary phases formation at 700 °C with lower electrical conductivity than BICUVOX.10.

In spite of such extensive research in the employment of BICUVOX.10 as a cathode material in doped-ceria electrolytes, there are no studies demonstrating the compatibility of BICUVOX.10 as a composite cathode applied in stabilized zirconia. This paper describes reactions and phase transformations in a modeled interface between BICUVOX.10 and yttria-stabilized zirconia (YSZ), focusing on the properties of the secondary phases formed and how such products can influence the performance of BICUVOX.10(cathode) / YSZ(electrolyte)-based devices.

2. Experimental

2.1. Samples preparation

BICUVOX.10 (γ '-Bi₂V_{0.9}Cu_{0.1}O_{5.35}) was synthetized in a fusion reaction method using stoichiometric amounts of Bi₂O₃ (98%, Vetec), V₂O₅ (99.5%, Vetec) and CuO (99.8%, Mallinckrodt). In this method, the stoichiometric mixture was heated up to its melting point (900 °C) in a ZrO₂-Al₂O₃-SiO₂ crucible for 1h. Subsequently, the molten mixture was quenched in water at ~0 °C. In order to ensure better homogeneity, this melting \rightarrow water quenching step was repeated. The obtained powders were dry-milled until particle size of 0.65 µm. More details about this procedure were reported by H. Biz¹². Commercial yttria-stabilized zirconia powders containing 3 mol.% Y₂O₃ (3Y-TZP; tetragonal) and 8 mol.% Y₂O₃ (8YSZ; cubic) were obtained from Tosoh Corp.

In order to evaluate the interfacial reactions, a junction of BICUVOX.10 / 3Y-TZP was developed by placing a dense sample of BICUVOX.10 (95% theoretical density, average grain size of 3 µm) upon of a 3Y-TZP dense sample (99% theoretical density). Both samples were joined by heating to 955 °C for 2 h with heating/cooling rates of 5 °C/ min. The temperature of 955 °C used was experimentally optimized in order to avoid insufficient adhesion of the BICUVOX.10 / 3Y-TZP junction, as previously observed in other systems¹⁰. Characteristics of the reaction zone at the junction of BICUVOX.10/3Y-TZP were obtained from developing a composition with 50 wt.% BICUVOX.10 + 50 wt.% 3Y-TZP (50B/50Z3), which was mixed in a ball mill for 24 h, compacted under uniaxial pressure of 45 MPa and exposed to the same temperature conditions mentioned above for the junction BICUVOX.10/3Y-TZP. Evaluation of the reactions between cubic ZrO₂ and BICUVOX.10 was performed replacing the 3Y-TZP with 50 wt.% 8YSZ (50B/50Z8). However, emphasis was given to the study of reactions in tetragonal zirconia, considering that this polymorph is subject of studies for use as an electrolyte in SOFC at low temperature operation¹³, in which the composite cathodes made of BICUVOX.10 are more appropriate. In addition, during the development of this work, it was observed that a better understanding of the reaction aspects between BICUVOX.10/YSZ is obtained in the evaluation of the tetragonal polymorph.

2.2. SEM, XRD and impedance measurements

In order to characterize microstructural changes, the sample 50B/50Z3 was polished and thermally etched at 855 °C for 30 min. In the case of the BICUVOX.10 / 3Y-TZP junction, microstructure of fracture surface was examined without any previous treatment. SEM (FEI Inspect S 50) equipped with an energy dispersive X-ray spectrometer (EDX) was used to determine the chemical composition of the samples. The phases present in the samples were determined by X-ray diffraction (XRD, Siemens model

D5005) using Cu-K α radiation, 2 θ range of 20 to 65° with 0.02° step. Destabilization extension of the tetragonal \rightarrow monoclinic phase transition in ZrO₂ was calculated considering the volume fraction of the formed monoclinic phase (v_m), as estimated by Equation 1¹⁴.

$$v_{\rm m} = \frac{1.311 X_{\rm m}}{1+1.311 X_{\rm m}} \tag{1}$$

Where X_m is the integration of the intensities ratio (Equation 2) and I represents the diffraction intensity of the respective lattice plane in subscript.

$$X_{m} = \frac{I_{m(\bar{1}11)} + I_{m(111)}}{I_{m(\bar{1}11)} + I_{m(111)} + I_{t(101)}}$$
(2)

Samples for conductivity were prepared as cylindrical pellets with 1 mm in thickness and 8 mm in diameter. Pt electrodes were placed on the sample as electrical contacts. Impedance spectroscopy measurements were performed in a temperature range of 425-600 °C, frequencies from 1 to 10⁶ Hz and voltage amplitude of 0.1 V, using a Solartron SI 1260 impedance analyser.

2.3. Thermal expansion coefficient and tensile strength

Coefficients of linear thermal expansion (α) were determined using a dilatometer furnace NETZSCH model DIL402C. Sintered cylindrical samples of approximately 6 mm in length and 8 mm in diameter were analysed with a heating rate of 5 °C/min until 700 °C, and α was obtained between 150-700 °C.

Tensile strength assessment (σ_{rs}) was performed through diametral compression test¹⁵ following the Equation 3. Samples of 8 mm in diameter (D) and 4 mm in thickness (h) were developed for testing. The tensile strength values shown in this paper are an arithmetic mean from 4 samples. The tests were performed at room temperature in a universal electro-mechanical tester INSTRON series 5500R, with a load cell of 500 kg and test rate of 0.5 mm/min until the maximum force applied before rupture of the specimens take place (F). Data acquisition was performed by the Blue Hill[®] software.

$$\sigma_{\rm TS} = \frac{2F}{\pi Dh} \tag{3}$$

3. Results

As shown in the interfacial junction, Figures 1a and b, the formation of a reaction zone occurs with height larger than 10 μ m consisting mainly of Zr with traces of other elements such as Bi, V and Cu. This reaction zone has higher porosity and disorder than the vicinity. X-ray diffraction patterns, Figures 1c-e, show that the sample that simulates the products formed by the reaction conserves the phase γ^{2} -Bi₂V_{0.9}Cu_{0.1}O_{5.35}. Nevertheless, when comparing the specimen which simulates the reaction zone (50B/50Z3) with 3Y-TZP, it is possible to observe a reduction of intensity of the (101) crystallographic plane of the tetragonal phase and a related increase at the (111) and (-111) peaks of the



Figure 1. (a) Reaction zone created by interaction between BICUVOX.10 and 3Y-TZP. (b) Reaction zone magnification (5000x) linked to EDX analysis. X-ray diffraction patterns for (c) BICUVOX.10, (d) 50B/50Z3 and (e) 3Y-TZP. The crystallographic planes used to measure the extent of destabilization are shown in the X-ray diffraction patterns.

monoclinic phase. Hence, the extent of destabilization calculated by the volume fraction of monoclinic phase reached 86 v.% for the sample 50B/50Z3. Furthermore, in the sample 50B/50Z3 the destabilization of tetragonal zirconia is accompanied by the formation of yttrium vanadate (YVO_4), as identified by X-ray diffraction.

Secondary phases formed in the reaction zone are the same found in the 50B/50Z3, since they were thermally treated under the same conditions. Observing the 50B/50Z3 sample in Figure 2, the γ^2 -Bi₂V_{0.9}Cu_{0.1}O_{5.35} phase (white region) settles preferably among the monoclinic zirconia and yttrium vanadate crystals. An excessive growth of prismatic monoclinic ZrO₂ crystals, reaching 7 µm in length has also been observed. In the case of the sample 50B/50Z8, it is possible to observe by the X-ray diffraction patterns in the Figure 3 that cubic ZrO₂ was also destabilized to the monoclinic polymorph. The product originated in the interaction between BICUVOX.10 / 8YSZ was YVO₄ - the same phase obtained when reacting BICUVOX.10 and 3Y-TZP.

Figure 4 shows that the thermal expansion coefficient and tensile strength of 50B/50Z3 are lower than those found for 3Y-TZP. For instance, as to the tensile strength - which had the most marked reduction - the 50B/50Z3 sample showed one third of the measured resistance of 3Y-TZP. Likewise, the electrical conductivity assessment in 50B/50Z3, Figure 5, shows that the electrical conductivity of such material is lower as compared to BICUVOX.10 and 3Y-TZP. At 500 °C the electrical conductivity displayed by 50B/50Z3 was of $6.2x10^{-7}$ S.cm⁻¹, whereas for BICUVOX.10 it was of approximately $4.6x10^{-2}$ S.cm⁻¹. Nevertheless, the activation energy of 1.71 eV found for 50B/50Z3 is considerably larger than that for BICUVOX.10, 0.57 eV.



Figure 2. Backscattered electron micrograph of the sample 50B/50Z3. Phases and products derived from reactions between BICUVOX.10 and 3Y-TZP are indicated by arrows.

4. Discussion

As observed in X-ray diffraction, in both 3Y-TZP (Figure 1d) and 8YSZ (Figure 3b), the interaction between yttria-stabilized zirconia and BICUVOX.10 results in high-temperature ZrO_2 polymorphs destabilization and YVO_4 formation. The production of yttrium vanadate and destabilization of tetragonal/cubic ZrO_2 polymorphs can be understood considering the Reaction 4. The YVO_4 formation occurs due to the reaction between the $YO_{1.5}$ stabilizer cation from ZrO_2 and $VO_{2.5}$ from γ^2 -Bi₂ $V_{0.9}Cu_{0.1}O_{5.35}$. Some studies^{16,17} have shown yttrium



Figure 3. X-ray diffraction patterns for (a) BICUVOX.10, (b) 50B/50Z8 and (c) 8YSZ. Crystallographic planes of ZrO_2 monoclinic polymorph are shown in (b).



Figure 4. (a) Coefficients of linear thermal expansion for 3Y-TZP, BICUVOX.10 and 50B/50Z3, which represent the reaction zone. (b) Diametral tensile strength for 3Y-TZP, BICUVOX.10 and 50B/50Z3. Diametral tensile strength graph exhibits only the mean values.

vanadate as a thermodynamically favorable product when vanadia and yttria react (Reaction 5). Hence, YVO_4 formation is intimately related to ZrO_2 destabilization, since depletion of the stabilizer cation from ZrO_2 structure results in the transformation of tetragonal or cubic phase into the most stable ZrO_2 polymorph at room temperature, i.e., the monoclinic polymorph. Corrosion studies of YSZ for thermal barrier coatings have shown that zirconia destabilization through the reaction with vanadium does not occur at temperatures below 800 °C¹⁸. Notwithstanding, the massive diffusion displayed by the V⁵⁺ ions at 800 °C is sufficient for the nucleation of YVO_4 crystals¹⁹. A.J. Samson et al.¹⁰ showed that temperatures higher than 800 °C are crucial to promote adhesion using BICUVOX.10 as cathode for ceria-doped electrolytes. The aforementioned fact indicates that Reaction 4 is of paramount importance for this system, since BICUVOX.10 / YSZ-based devices certainly will require high temperatures – or at least, temperatures similar to the ceria-doped case – to promote good adhesive characteristics.

$$Zr_{1,x}Y_{x}O_{2,0,5x}(\text{tetragonal or cubic}) + \gamma'-Bi_{2}V_{0,9}Cu_{0,1}O_{5,35} \rightarrow ZrO_{2}(\text{monoclinic}) + \gamma'-Bi_{2}V_{0,9,x}Cu_{0,1}O_{5,35} + xYVO_{4}$$
(4)

$$YO_{15} + VO_{25} \to YVO_4 \tag{5}$$

In order to further understand Reaction 4, a theoretical mechanism was proposed to explain the ZrO_2 destabilization using a charge-compensating dopants description¹⁹. Primarily, the destabilization mechanism is derived from two aspects of the ZrO_2 structure; one of them establishes that when ZrO_2 co-doping with M⁵⁺ and M³⁺ cations occurs, the negative charge of M³⁺ \rightarrow Zr⁴⁺ (M'_{Zr}) substitution will be



Figure 5. Arrhenius plot for BICUVOX.10, 3Y-TZP and 50B/50Z3, indicating the effects of reactions and phase transformations in the electrical conductivity.

directly compensated by the positive charge generated by $M^{5+} \rightarrow Zr^{4+} (M_{Zr}^{\square})^{19-21}$. Secondly, the ability of tetragonal or cubic ZrO, polymorphs being stabilized at room temperature arises due to the lower coordination of Zr⁴⁺ ions when oxygen vacancies are generated by M3+ doping22. Such ZrO, destabilization model shows the link between the tetragonal or cubic to monoclinic transformation with the YVO₄ secondary phase nucleation. As shown in Figure 6, considering the oxygen vacancies available in the ZrO₂ doping with Y_2O_3 (I), when V^{5+} provided by γ' -Bi₂V_{0.9}Cu_{0.1}O_{5.35} diffuses into the stabilized ZrO₂ lattice, thus replacing the zirconium ions, a consumption of oxygen vacancies initially generated by the yttrium doping (II) takes place. Crystal electroneutrality demands that the charge sum of all point defects must be null. A limitation in the quantity of V⁵⁺ in the Zr⁴⁺ positions occurs since V⁵⁺ \rightarrow Zr⁴⁺ replacement occurs only while oxygen vacancies exist, converging to the same concentration $[Y'_{Zr}] = [V^{\square}_{Zr}]$. When this equimolarity for the two cations is reached (III), all the oxygen vacancies generated by [Y'_{Zr}] are consumed by $\begin{bmatrix} V_{Zr}^{\Box} \end{bmatrix}$. Consequently, the oxygen vacancies responsible for the initial stabilization of tetragonal or cubic polymorphs are extinct and the precipitation of YVO4 from stabilized ZrO, takes place.

Although the YVO_4 formation is derived only on the diffusion from V⁵⁺ ions into the zirconia lattice, the effect of liquid BICUVOX.10 should play a significant role in this mechanism. As bismuth vanadate solid solutions undergo incongruent melting at 880 °C²³, some solution-precipitation reaction could occur at temperatures higher than that, therefore, accelerating interfacial reactions between BICUVOX.10 and YSZ. Moreover, temperatures above of BICUVOX.10 melting point also result in excessive grain growth. As shown in Figure 1a, BICUVOX.10 grains of originally 3 µm reach almost 100 µm after reaction tests at



Figure 6. Proposed mechanisms for high-temperature ZrO_2 polymorphs destabilization and YVO_4 nucleation. This charge-compensating dopants description mechanism is explained into three main steps. The Kröger-Vink notation for the $\begin{bmatrix} V_{Zr}^{T} \end{bmatrix}$ defect may be confusing, because the V symbol, which represents vanadium ion, has always been applied to describe a vacancy defect. However, in this schematic representation, $\begin{bmatrix} V_{Zr}^{T} \end{bmatrix}$ represents one V⁵⁺ ion replacing the Zr⁴⁺ cation into the ZrO₂ lattice.

955 °C. This same effect was previously reported by A.J. Samson et al.¹⁰.

As seen in the properties of 50B/50Z3 sample, the YVO_4 formation and ZrO_2 destabilization have brought strong influences in the junction behaviour. The low thermal expansion coefficient and tensile strength of the 50B/50Z3 sample in relation to 3Y-TZP are originated from highly disordered and defect-rich regions when the reactions showed in Reaction 4 take place. Considering the destabilization mechanism proposed in this paper, the volumetric expansion caused by the transition from tetragonal to monoclinic ZrO_2 and YVO_4 crystal growth is responsible for the highly disordered region observed in the reaction zone. These interfacial defects act as points of high stress concentration, leading to the deterioration of the mechanical strength seen in the 50B/50Z3 sample.

Although it has been shown that reaction will undoubtedly bring about modifications in the properties of the BICUVOX.10/3Y-TZP junction, the more deleterious effect observed was the low electrical conductivity of the reaction products. For the 50B/50Z3 sample, which represents the reaction zone, electrical conductivity was five times smaller than that of BICUVOX.10. This effect demonstrates that when YVO_4 formation and ZrO_2 destabilization occur, the reacted layer in the contact region between BICUVOX.10 and YSZ will act hindering any catalytic effect initially expected by using BICUVOX.10 as a composite cathode. Indeed, this tendency to reaction might be reduced if low temperature adhesion techniques were employed. Nevertheless, finding a temperature which allows good adhesion and avoids reactions in BICUVOX.10-based cathodes is still a topic of current research¹⁰.

5. Conclusions

Reactions between BICUVOX.10 and YSZ were investigated and reported in this paper. Developing samples consisting of cathode and electrolyte materials in equal parts has shown to be a useful tool to characterize the reactions in the cathode/electrolyte interface. When BICUVOX.10 reacts with YSZ, the high temperature ZrO₂ polymorphs - tetragonal and cubic - are destabilized to monoclinic. In addition, an YVO₄ phase nucleates, a phenomenon which was attributed to the V^{5+} cation diffusion into the stabilized-ZrO, lattice. Furthermore, these products have shown to be detrimental to the junction, since they lead to the deterioration of the electrolyte mechanical strength and to low electrical conductivity. In short, the application of BICUVOX.10 as highly catalytic component in the composite cathode used in yttria-stabilized zirconia electrolytes is restricted since both YVO4 formation and ZrO₂ destabilization lead to poor properties of the junction.

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